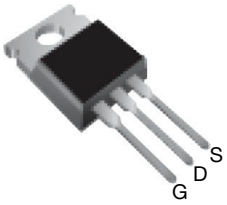
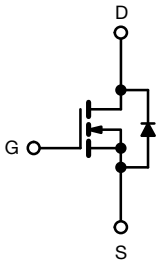
# EF Series Power MOSFET With Fast Body Diode

TO-220AB




N-Channel MOSFET

## FEATURES

- 4th generation E series technology
- Low figure-of-merit (FOM) $R_{on}$ x $Q_g$
- Low effective capacitance ($C_{o(er)}$)
- Reduced switching and conduction losses
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

RoHS COMPLIANT HALOGEN FREE

## APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Motor drives
  - Battery chargers
  - Solar (PV inverters)

| PRODUCT SUMMARY | | |
|---|---|---|
| $V_{DS}$ (V) at $T_J$ max. | 650 | |
| $R_{DS(on)}$ typ. (Ω) at 25 °C | $V_{GS}$ = 10 V | 0.059 |
| $Q_g$ max. (nC) | 77 | |
| $Q_{gs}$ (nC) | 19 | |
| $Q_{gd}$ (nC) | 16 | |
| Configuration | Single | |

| ORDERING INFORMATION | |
|---|---|
| Package | TO-220AB |
| Lead (Pb)-free and halogen-free | SiHP068N60EF-GE3 |

**ABSOLUTE MAXIMUM RATINGS** ($T_C$ = 25 °C, unless otherwise noted)

| PARAMETER | | | SYMBOL | LIMIT | UNIT |
|---|---|---|---|---|---|
| Drain-source voltage | | | $V_{DS}$ | 600 | V |
| Gate-source voltage | | | $V_{GS}$ | ± 30 | |
| Continuous drain current ($T_J$ = 150 °C) | $V_{GS}$ at 10 V | $T_C$ = 25 °C | $I_D$ | 41 | A |
| | | $T_C$ = 100 °C | | 26 | |
| Pulsed drain current [a] | | | $I_{DM}$ | 115 | |
| Linear derating factor | | | | 2 | W/°C |
| Single pulse avalanche energy [b] | | | $E_{AS}$ | 226 | mJ |
| Maximum power dissipation | | | $P_D$ | 250 | W |
| Operating junction and storage temperature range | | | $T_J$, $T_{stg}$ | -55 to +150 | °C |
| Drain-source voltage slope | $T_J$ = 125 °C | | dV/dt | 70 | V/ns |
| Reverse diode dV/dt [d] | | | | 50 | |
| Soldering recommendations (peak temperature) [c] | For 10 s | | | 260 | °C |

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature
b. $V_{DD}$ = 120 V, starting $T_J$ = 25 °C, L = 28.2 mH, $R_g$ = 25 Ω, $I_{AS}$ = 4 A
c. 1.6 mm from case
d. $I_{SD} \leq I_D$, di/dt = 210 A/µs, starting $T_J$ = 25 °C

| THERMAL RESISTANCE RATINGS | | | |
|---|---|---|---|
| **PARAMETER** | **SYMBOL** | **LIMIT** | **UNIT** |
| Maximum junction-to-ambient | $R_{thJA}$ | 62 | °C/W |
| Maximum junction-to-case (drain) | $R_{thJC}$ | 0.5 | |

**SPECIFICATIONS** ($T_J$ = 25 °C, unless otherwise noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|---|---|---|
| **Static** | | | | | | |
| Drain-source breakdown voltage | $V_{DS}$ | $V_{GS}$ = 0 V, $I_D$ = 250 µA | 600 | - | - | V |
| $V_{DS}$ temperature coefficient | $\Delta V_{DS}/T_J$ | Reference to 25 °C, $I_D$ = 1 mA | - | 0.63 | - | V/°C |
| Gate-source threshold voltage (N) | $V_{GS(th)}$ | $V_{DS}$ = $V_{GS}$, $I_D$ = 250 µA | 3 | - | 5 | V |
| Gate-source leakage | $I_{GSS}$ | $V_{GS}$ = ± 20 V | - | - | ± 100 | nA |
| | | $V_{GS}$ = ± 30 V | - | - | ± 1 | µA |
| Zero gate voltage drain current | $I_{DSS}$ | $V_{DS}$ = 480 V, $V_{GS}$ = 0 V | - | - | 1 | µA |
| | | $V_{DS}$ = 480 V, $V_{GS}$ = 0 V, $T_J$ = 125 °C | - | - | 2 | mA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}$ = 10 V, $I_D$ = 16 A | - | 0.059 | 0.068 | Ω |
| Forward transconductance | $g_{fs}$ | $V_{DS}$ = 30 V, $I_D$ = 16 A | - | 9 | - | S |
| **Dynamic** | | | | | | |
| Input capacitance | $C_{iss}$ | $V_{GS}$ = 0 V, $V_{DS}$ = 100 V, f = 1 MHz | - | 2628 | - | pF |
| Output capacitance | $C_{oss}$ | | - | 122 | - | |
| Reverse transfer capacitance | $C_{rss}$ | | - | 7 | - | |
| Effective output capacitance, energy related [a] | $C_{o(er)}$ | $V_{DS}$ = 0 V to 480 V, $V_{GS}$ = 0 V | - | 87 | - | |
| Effective output capacitance, time related [b] | $C_{o(tr)}$ | | - | 543 | - | |
| Total gate charge | $Q_g$ | $V_{GS}$ = 10 V; $I_D$ = 16 A, $V_{DS}$ = 480 V | - | 51 | 77 | nC |
| Gate-source charge | $Q_{gs}$ | | - | 19 | - | |
| Gate-drain charge | $Q_{gd}$ | | - | 16 | - | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}$ = 480 V, $I_D$ = 16 A, $V_{GS}$ = 10 V, $R_g$ = 9.1 Ω | - | 27 | 54 | ns |
| Rise time | $t_r$ | | - | 55 | 83 | |
| Turn-off delay time | $t_{d(off)}$ | | - | 53 | 80 | |
| Fall time | $t_f$ | | - | 35 | 70 | |
| Gate input resistance | $R_g$ | f = 1 MHz, open drain | 0.3 | 0.7 | 1.4 | Ω |
| **Drain-Source Body Diode Characteristics** | | | | | | |
| Continuous source-drain diode current | $I_S$ | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | 41 | A |
| Pulsed diode forward current | $I_{SM}$ | | - | - | 115 | |
| Diode forward voltage | $V_{SD}$ | $T_J$ = 25 °C, $I_S$ = 16 A, $V_{GS}$ = 0 V | - | - | 1.2 | V |
| Reverse recovery time | $t_{rr}$ | $T_J$ = 25 °C, $I_F$ = $I_S$ = 16 A, di/dt = 100 A/µs, $V_R$ = 400 V | - | 152 | 304 | ns |
| Reverse recovery charge | $Q_{rr}$ | | - | 1 | 2 | µC |
| Reverse recovery current | $I_{RRM}$ | | - | 14 | - | A |

**Notes**

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as $C_{oss}$ while $V_{DS}$ is rising from 0 % to 80 % $V_{DSS}$

b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as $C_{oss}$ while $V_{DS}$ is rising from 0 % to 80 % $V_{DSS}$

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

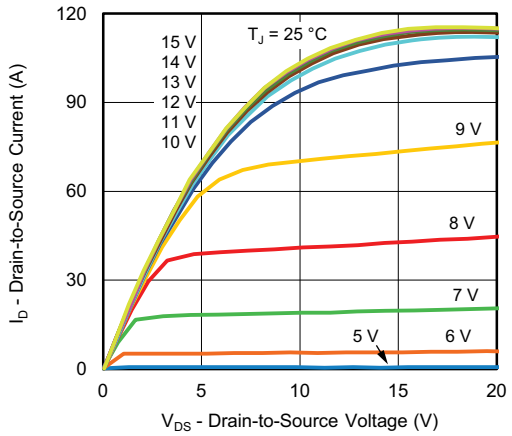



**Fig. 1 - Typical Output Characteristics**

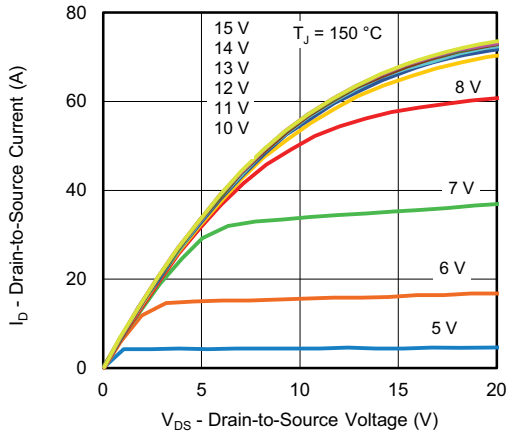



**Fig. 2 - Typical Output Characteristics**

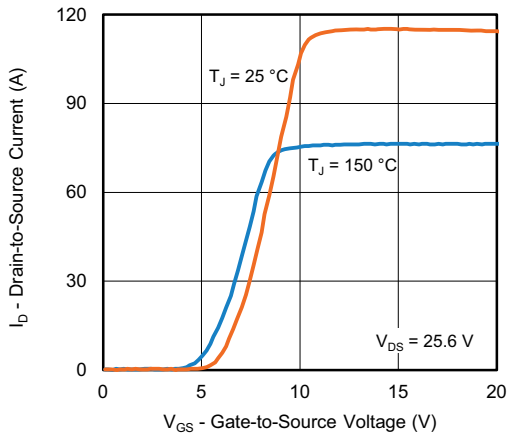



**Fig. 3 - Typical Transfer Characteristics**

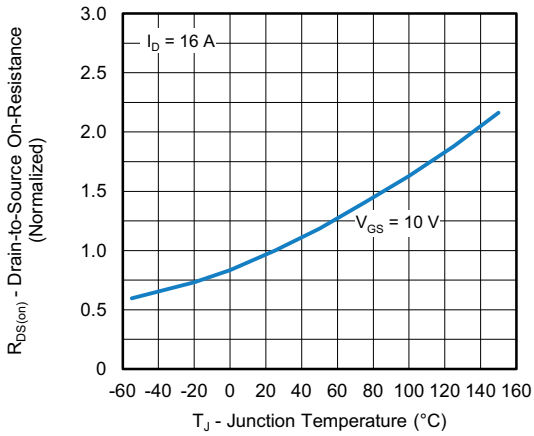



**Fig. 4 - Normalized On-Resistance vs. Temperature**

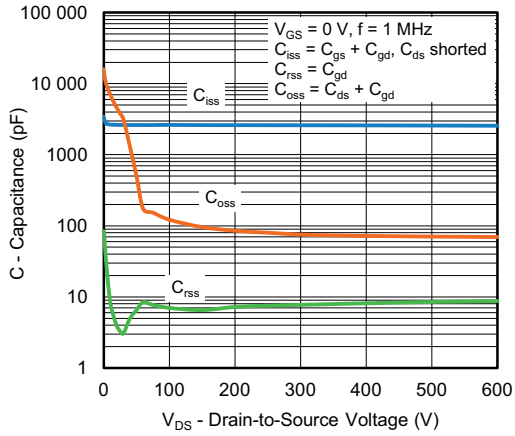



**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage**

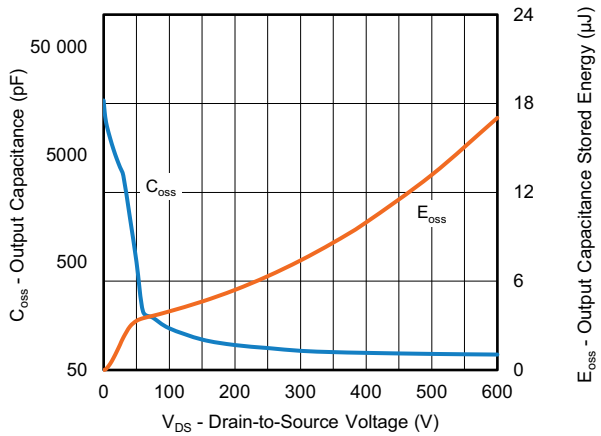



**Fig. 6 - $C_{oss}$ and $E_{oss}$ vs. $V_{DS}$**

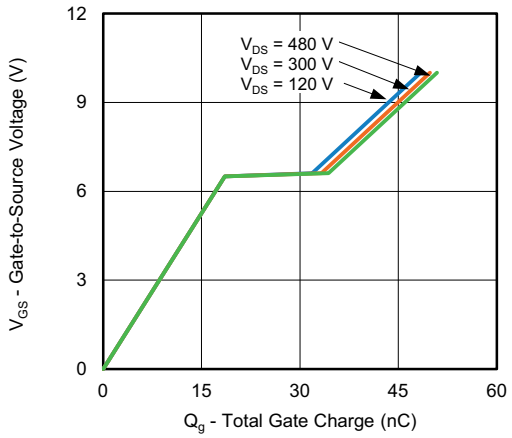



**Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage**

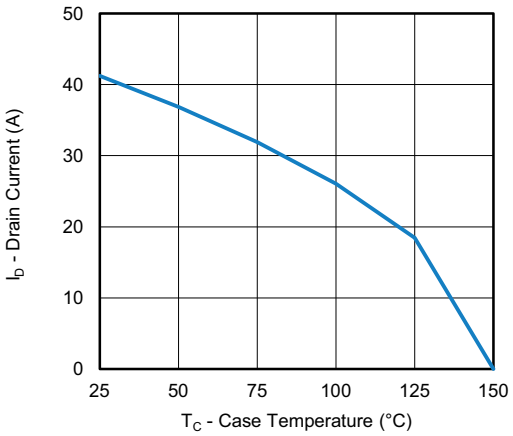



**Fig. 10 - Maximum Drain Current vs. Case Temperature**

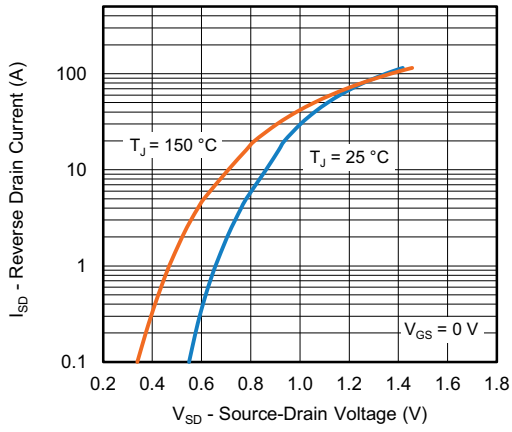



**Fig. 8 - Typical Source-Drain Diode Forward Voltage**

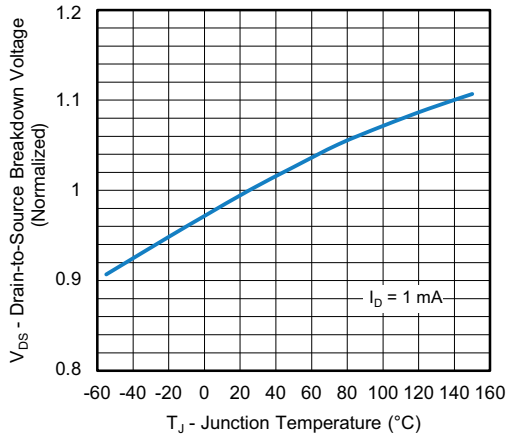



**Fig. 11 - Temperature vs. Drain-to-Source Voltage**

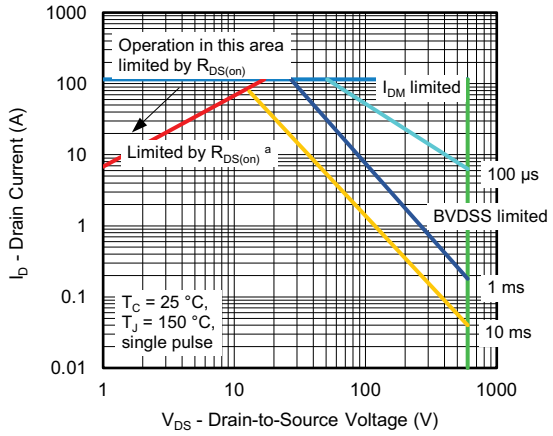



**Fig. 9 - Maximum Safe Operating Area**

**Note**

a. $V_{GS}$ > minimum $V_{GS}$ at which $R_{DS(on)}$ is specified

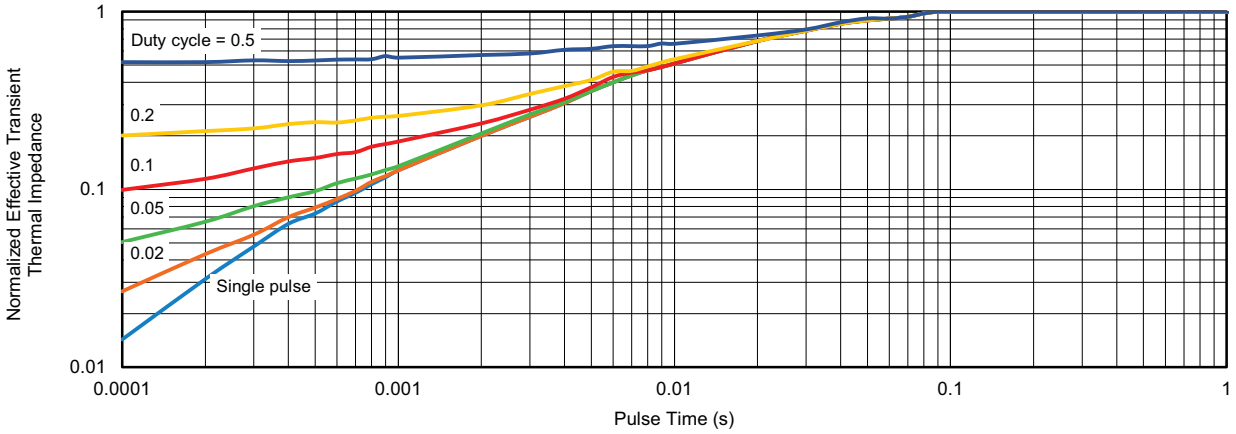



**Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case**

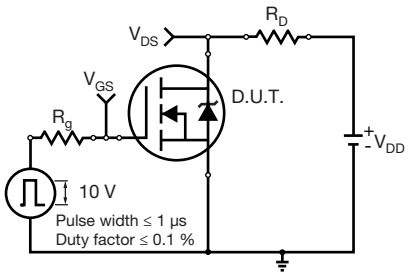



**Fig. 13 - Switching Time Test Circuit**

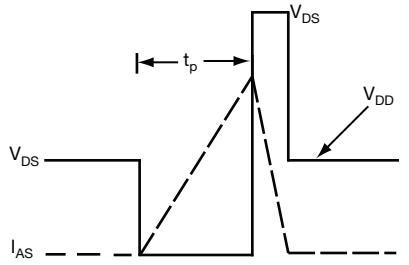



**Fig. 16 - Unclamped Inductive Waveforms**

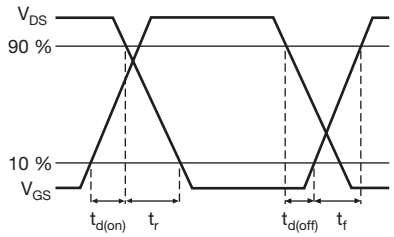



**Fig. 14 - Switching Time Waveforms**

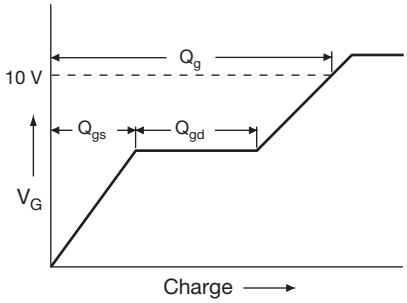



**Fig. 17 - Basic Gate Charge Waveform**

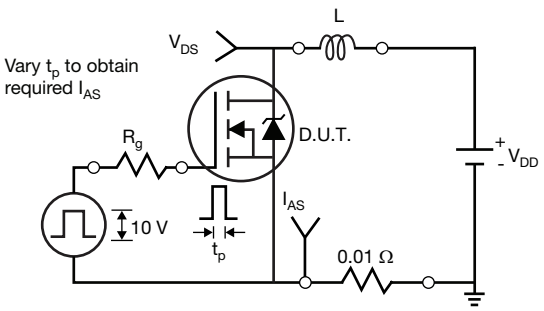



**Fig. 15 - Unclamped Inductive Test Circuit**

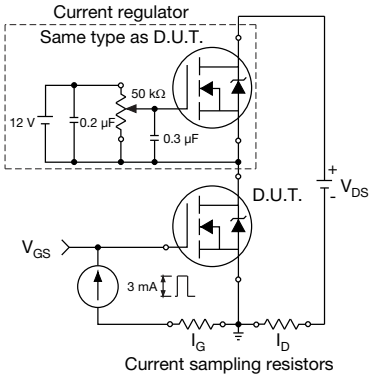
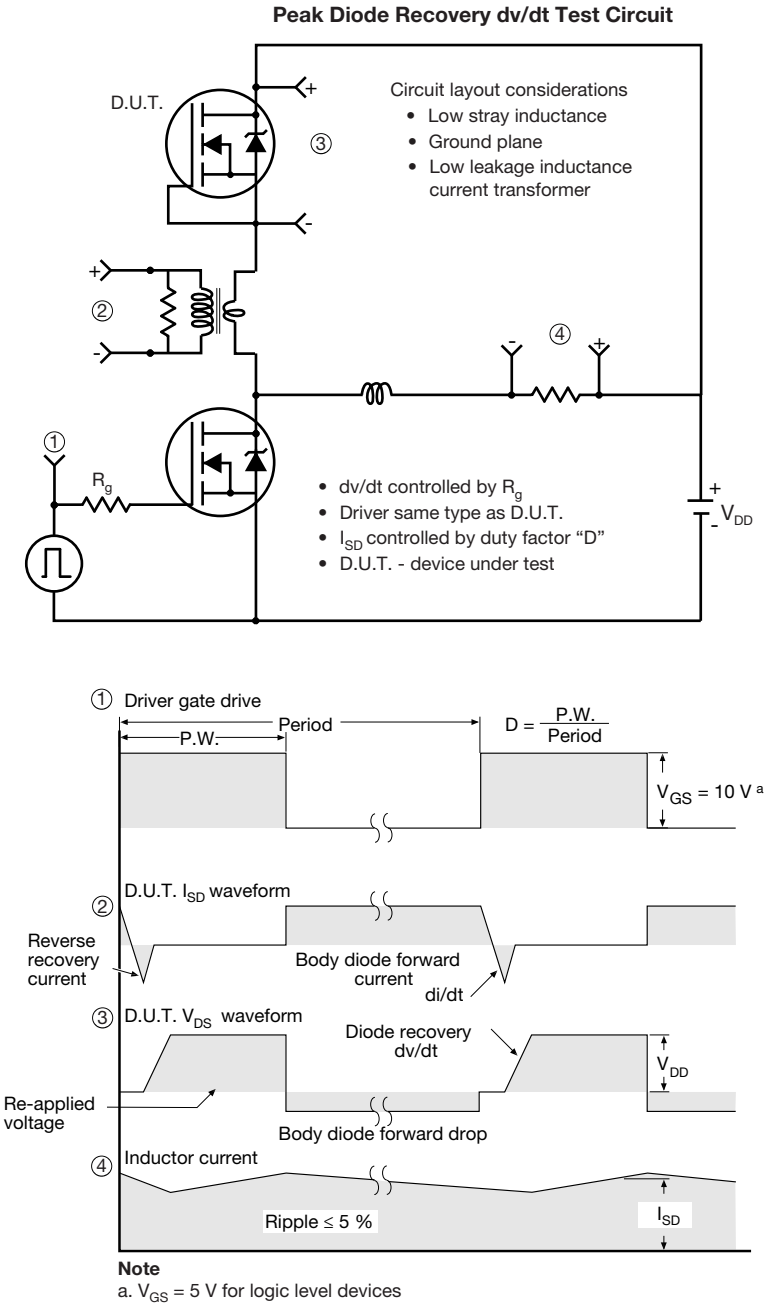



**Fig. 18 - Gate Charge Test Circuit**




**Note**

a. $V_{GS}$ = 5 V for logic level devices

**Fig. 19 - For N-Channel**

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